

FORM PTO-1449 (Modified)

ATTY. DOCKET NO.  
TS1099

APPLICATION NUMBER

10/509418

LIST OF INFORMATION PROVIDED  
BY APPLICANT

(Use several sheets if necessary)

APPLICANT  
PUIK, Eric, JohannesFILING DATE  
September 24, 2004GROUP ART UNIT  
2855

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Patentee	Class	Subclass	Filing Date if Appropriate
CW	AA	4660414	4/28/87	Gregory J. Hatton, et al	73	61.1	9/12/85
	AB	5378353	1/3/95	Berthold Koch	210	86	1/8/93
	AC	4563274	1/7/86	Stephen Rothon, et al	210	101	8/20/84
	AD	4698152	10/6/87	Noel Carroll	210	96.01	8/3/84
	AE	5064448	11/12/91	Michael S. Choi	55	38	1/9/91
	AF	4708793	11/24/87	Richard L. Cathriner, et al	210	188	6/13/86
	AG	6468335	10/22/02	Hugo G. Poldermann	96	183	4/12/00
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation	
							Yes	No
CW	AL	1044711	10/18/00	EP	B01D	17/025		
CW	AM	2077364 Database XP-002116078	4/20/97	RU and (English abstract)	B01D9	19/00		X
	AN							
	AO							

## OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

✓	AR	International Search Report dated 26 June 2003
	AS	
	AT	

EXAMINER

DATE CONSIDERED

1/24/06

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

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	AR	Kirk-Othmer, Encyclopedia of Chemical Technology, NY, 4 <sup>th</sup> Edition, Vol. 15, 1995, pp. 409-433
	AS	
	AT	

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